Notice of References Cited Application/Control No. 10/612,018 Examiner Akm Enayet Ullah U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination YONEDA, SHIGERU Art Unit 2874 Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-2003/0219212	11-2003	Kwon et al.	385/52
X	В	US-2003/0210858	11-2003	Kaneko, Tarou	385/24
X	С	US-2003/0198436	10-2003	Kaneko, Tarou	385/37
X	D	US-2002/0067890	06-2002	Yoneda, Shigeru	385/37
X	Ε	US-2002/0057869	05-2002	Kaneko, Tarou	385/24
X	F	US-2002/0009263	01-2002	Kashihara et al.	385/37
X	G	US-2001/0028762	10-2001	Kashihara et al.	385/37
X	Н	US-2001/0006570	07-2001	Kashihara et al.	385/24
X	ı	US-6,567,587	05-2003	Kashihara et al.	385/37
Х	J	US-6,563,986	05-2003	Kashihara et al.	385/37
X	К	US-6,490,395	12-2002	Nara et al.	385/39
X	L	US-6,377,723	04-2002	Saito et al.	385/15
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	R					
	s					
	Т					

NON-PATENT DOCUMENTS

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